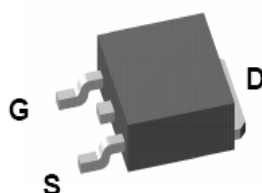


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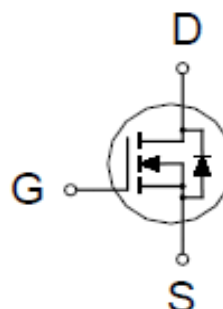
N-Channel Logic Level Enhancement Mode MOSFET

PRODUCT SUMMARY

$V_{(BR)DSS}$	$R_{DS(ON)}$	I_D
25V	7mΩ @ $V_{GS} = 10V$	75A



TO-252



ABSOLUTE MAXIMUM RATINGS ($T_A = 25\text{ °C}$ Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS		SYMBOL	LIMITS	UNITS
Gate-Source Voltage		V_{GS}	±20	V
Continuous Drain Current	$T_C = 25\text{ °C}$	I_D	75	A
	$T_C = 100\text{ °C}$		50	
Pulsed Drain Current ¹		I_{DM}	170	
Avalanche Current		I_{AS}	45	
Avalanche Energy	$L = 0.1\text{mH}$	E_{AS}	100	mJ
Power Dissipation	$T_C = 25\text{ °C}$	P_D	54	W
	$T_C = 100\text{ °C}$		32.75	
Operating Junction & Storage Temperature Range		T_J, T_{stg}	-55 to 150	°C

THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE	SYMBOL	TYPICAL	MAXIMUM	UNITS
Junction-to-Case	$R_{\theta JC}$		2.3	°C / W
Junction-to-Ambient	$R_{\theta JA}$		62.5	
Case-to-Heatsink	$R_{\theta CS}$	0.6		

¹Pulse width limited by maximum junction temperature.

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ELECTRICAL CHARACTERISTICS (T_J = 25 °C, Unless Otherwise Noted)

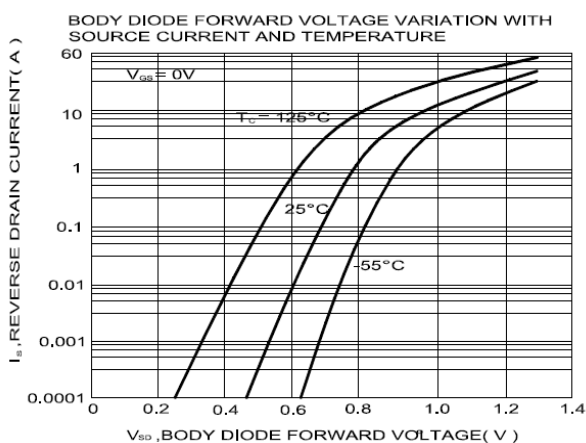
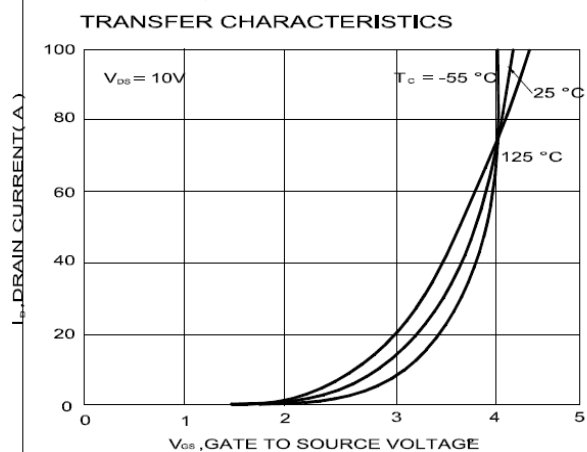
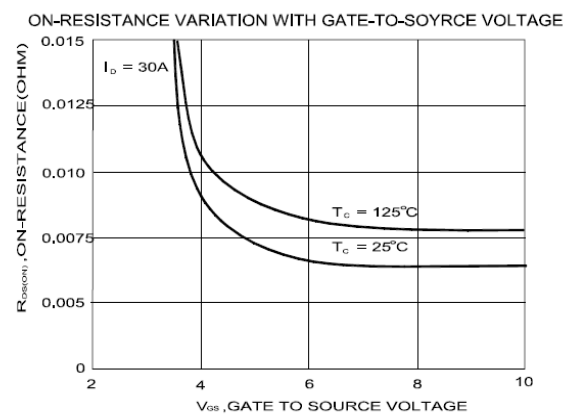
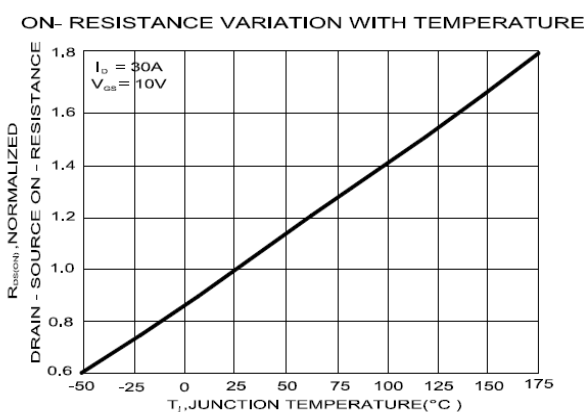
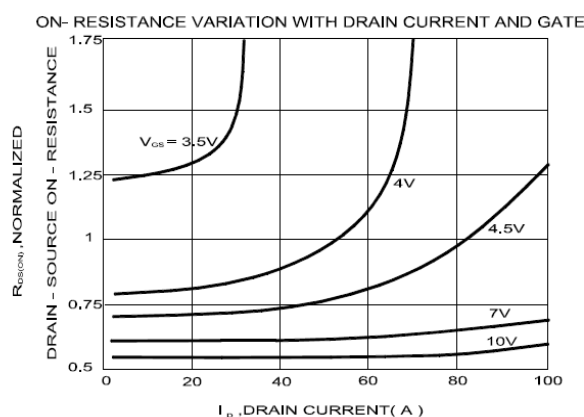
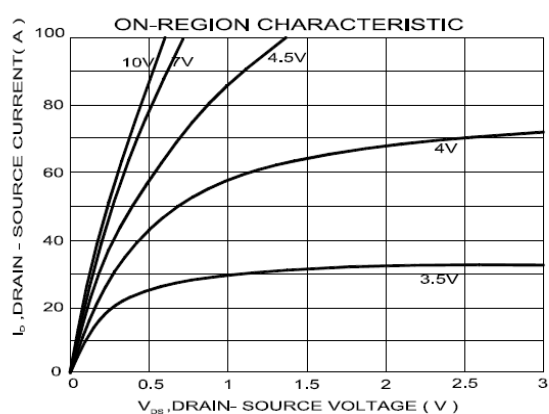
PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNITS
			MIN	TYP	MAX	
STATIC						
Drain-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0V, I _D = 250μA	25			V
Gate Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250μA	1	1.5	3	
Gate-Body Leakage	I _{GSS}	V _{DS} = 0V, V _{GS} = ±20V			±250	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =20V, V _{GS} = 0V			25	μA
		V _{DS} =20V, V _{GS} = 0V, T _J = 125°C			250	
On-State Drain Current ¹	I _{D(ON)}	V _{DS} = 10V, V _{GS} = 10V	170			A
Drain-Source On-State Resistance ¹	R _{DS(ON)}	V _{GS} =5V, I _D =24A		6.5	10	mΩ
		V _{GS} =10V, I _D =30A		5.1	7	
Forward Transconductance ¹	g _{fs}	V _{DS} =15V, I _D =30A		55		S
DYNAMIC						
Input Capacitance	C _{iss}	V _{GS} = 0V, V _{DS} = 15V, f = 1MHz		1825		pF
Output Capacitance	C _{oss}			717		
Reverse Transfer Capacitance	C _{rss}			553		
Gate Resistance	R _g	V _{GS} = 0V, V _{DS} = 0V, f = 1MHz		1.25		Ω
Total Gate Charge ²	Q _{g(10V)}	V _{DD} = 15V I _D = 25A		55		nC
	Q _{g(5V)}			30		
Gate-Source Charge ²	Q _{gs(10V)}			9.4		
	Q _{gs(5V)}			8.8		
Gate-Drain Charge ²	Q _{gd(10V)}			19.6		
	Q _{gd(5V)}			19		
Turn-On Delay Time ²	t _{d(on)}	V _{DS} = 15V , I _D ⩽ 30A, V _{GS} = 10V, R _G =2.5Ω		11.5		nS
Rise Time ²	t _r			17		
Turn-Off Delay Time ²	t _{d(off)}			32		
Fall Time ²	t _f			7.5		
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS (T _J = 25 °C)						
Continuous Current	I _S				40	A
Forward Voltage ¹	V _{SD}	I _F = 30A, V _{GS} = 0V			1.3	V
Reverse Recovery Time	t _{rr}	I _F = 30A, dI _F /dt = 100A / μs		37		nS
Peak Reverse Recovery Current	I _{RM(REC)}			200		A
Reverse Recovery Charge	Q _{rr}			0.042		μC

¹Pulse test : Pulse Width ≤ 300 μsec, Duty Cycle ≤ 2%.

²Independent of operating temperature.

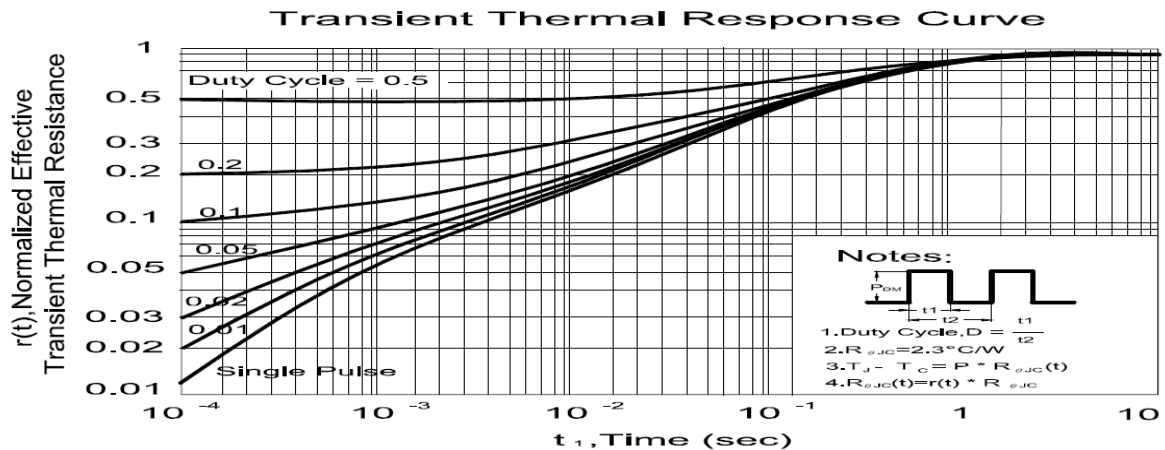
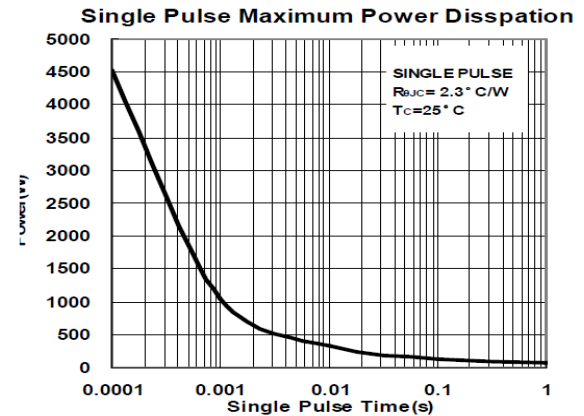
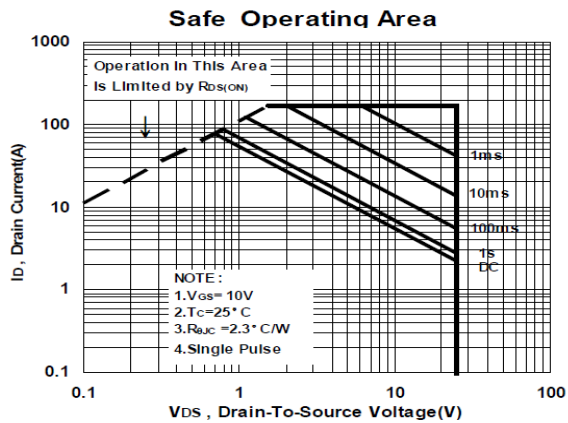
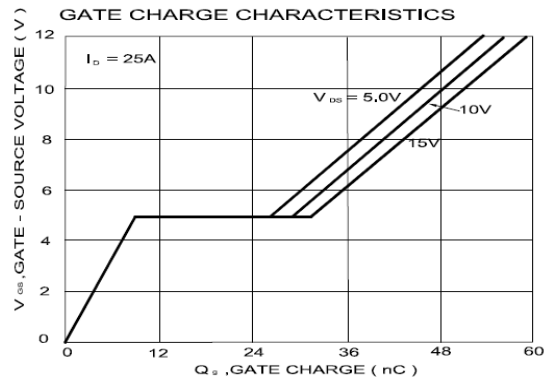
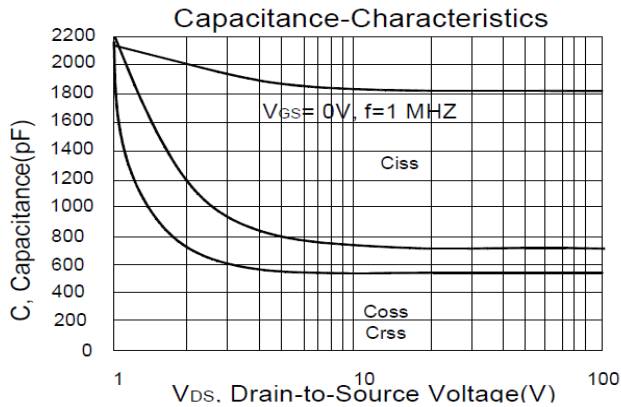
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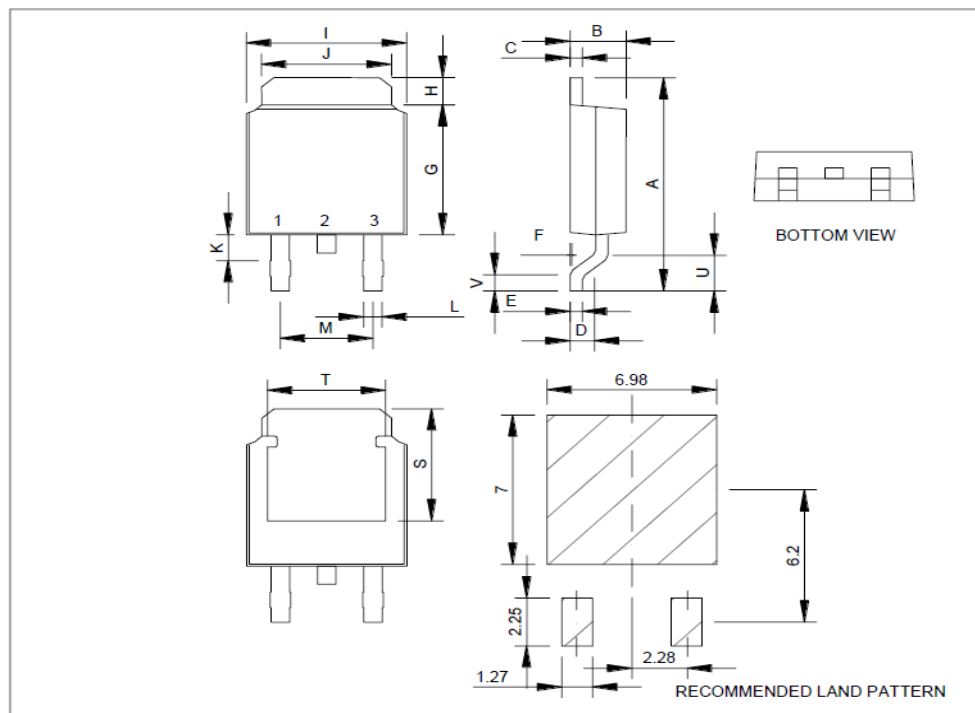
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N-Channel Logic Level Enhancement Mode MOSFET

Package Dimension

TO-252 (DPAK) MECHANICAL DATA

Dimension	mm			Dimension	mm		
	Min.	Typ.	Max.		Min.	Typ.	Max.
A	8.9	10	10.41	J	4.8		5.64
B	2.1	2.2	2.4	K	0.15		1.1
C	0.4	0.5	0.61	L	0.4	0.76	0.89
D	0.82	1.2	1.5	M	4.2	4.58	5
E	0.4	0.5	0.61	S	4.9	5.1	5.3
F	0		0.2	T	4.6	4.75	5.44
G	5.3	6.1	6.3	U	1.4		1.78
H	0.9		1.7	V	0.55	1.25	1.7
I	6.3	6.5	6.8				



*因为各家封装模具不同而外观略有所差异，不影响电性及Layout。